


<b>Search Notes</b>  	<b>Application/Control No.</b>  10613733	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAHASHI, KENJI
	<b>Examiner</b>  Seth, Manav	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	162-167	2/20/2007	ms
348	21.99,222.1,223.1,225.1,237,272-280	2/20/2007	ms
358	500,515-523	2/21/2007	ms

SEARCH NOTES		
Search Notes	Date	Examiner
East (Text and class) search - see attached search notes	2/23/2007	ms
IEEE Search	2/21/2007	ms
STIC PLUS Search	2/21/2007	ms
Inventor Search	2/23/2007	ms
Interference Search	2/23/2007	ms
Consulted Wenpeng Chen (Primary Examiner)	2/20/2007	ms
Consulted Ishrat Sherali (Primary Examiner)	2/20/2007	ms
Consulted Vikram Bali (Primary Examiner)	2/20/2007	ms
Consulted Bhavesh Mehta (SPE)	2/22/2007	ms

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	PGPUB Text Search	2/23/2007	ms